

SANYO

No. 1579D

2SC3456

NPN Triple Diffused Planar Silicon Transistor
FOR SWITCHING REGULATORS

Features

- . High breakdown voltage and high reliability.
- . Fast switching speed (tf: 0.1µs typ).
- . Wide ASO.
- . Adoption of MBIT process.

Absolute Maximum Ratings at Ta=25°C

			unit
Collector-to-Base Voltage	V _{CB0}	1100	V
Collector-to-Emitter Voltage	V _{CEO}	800	V
Emitter-to-Base Voltage	V _{EBO}	7	V
Collector Current	I _C	1.5	A
Peak Collector Current	i _{cp}	5	A
Base Current	I _B	0.8	A
Collector Dissipation	P _C	40	W
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Notes: P_C and T_J are limited by P_W ≤ 300µs, Duty Cycle ≤ 10%. T_C = 25°C

Electrical Characteristics at Ta=25°C

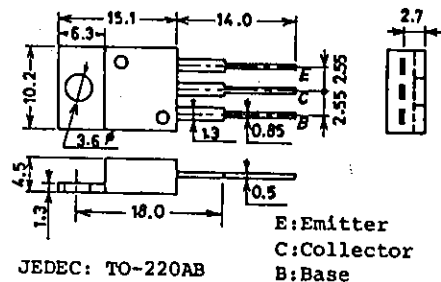
			min	typ	max	unit
Collector Cutoff Current	I _{CB0}	V _{CB} =800V, I _E =0			10	µA
Emitter Cutoff Current	I _{EBO}	V _{EB} =5V, I _C =0			10	µA
DC Current Gain	h _{FE} (1)	V _{CE} =5V, I _C =0.1A	10*		40*	
	h _{FE} (2)	V _{CE} =5V, I _C =0.5A	8			
Gain-Bandwidth Product	f _T	V _{CE} =10V, I _C =0.1A		15		MHz
Output Capacitance	C _{ob}	V _{CB} =10V, f=1MHz		35		pF
Collector-to-Emitter Saturation Voltage	V _{CE(sat)}	I _C =0.75A, I _B =0.15A			2.0	V
Base-to-Emitter Saturation Voltage	V _{BE(sat)}	I _C =0.75A, I _B =0.15A			1.5	V
Collector-to-Base Breakdown Voltage	V _{(BR)CBO}	I _C =1mA, I _E =0	1100			V
Collector-to-Emitter Breakdown Voltage	V _{(BR)CEO}	I _C =5mA, R _{BE} =∞	800			V
Emitter-to-Base Breakdown Voltage	V _{(BR)EBO}	I _E =1mA, I _C =0	7			V

Continued on next page.

*: The h_{FE}(1) of the 2SC3456 is classified as follows. When specifying the h_{FE}(1) rank, specify two ranks or more in principle.

10	K	20	15	L	30	20	M	40
----	---	----	----	---	----	----	---	----

Package Dimensions 2010A
(unit:mm)



Continued from preceding page.

Collector-to-Emitter Sustain Voltage $V_{CEX(sus)}$

$I_C=0.75A$
 $I_{B1}=-I_{B2}=0.15A$,
 $L=5mH$, clamped

min typ max unit
 800 V

Turn-on Time t_{on}

Fall Time t_{stg}

Storage Time t_f

t_{on}

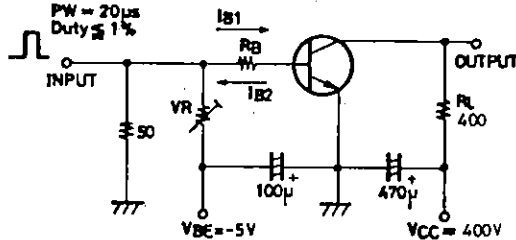
t_{stg}

t_f

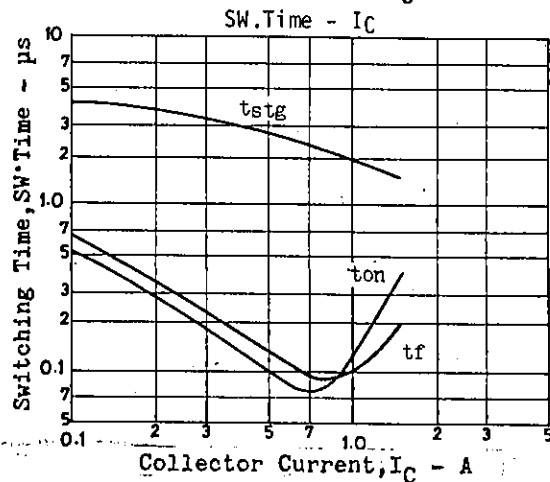
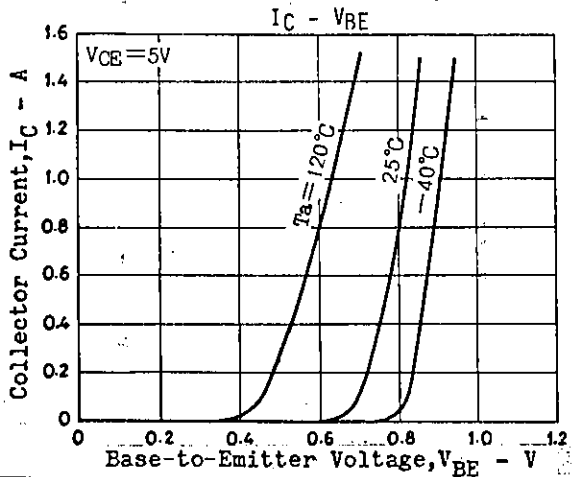
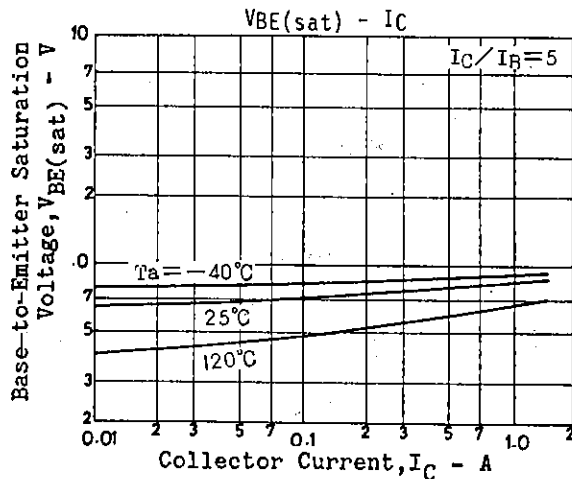
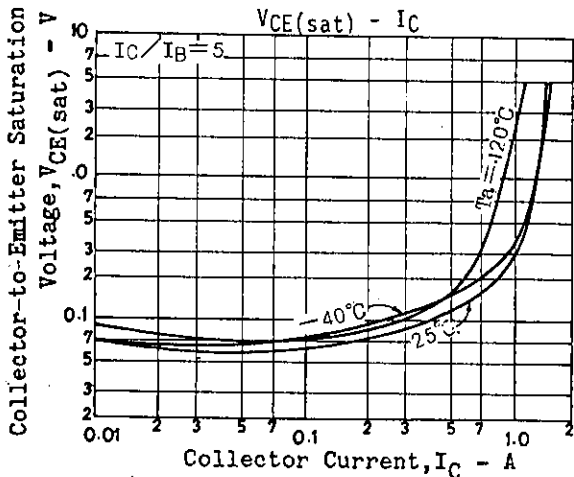
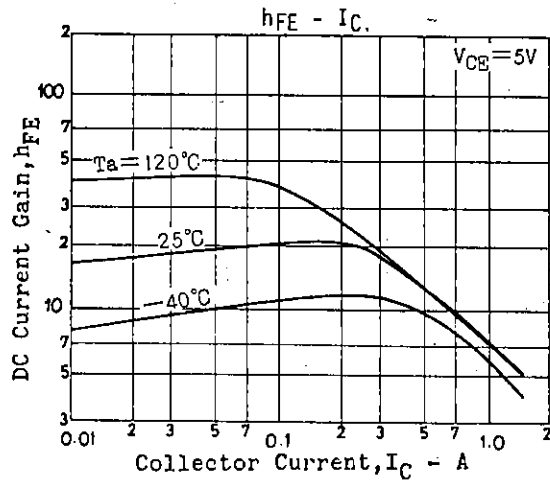
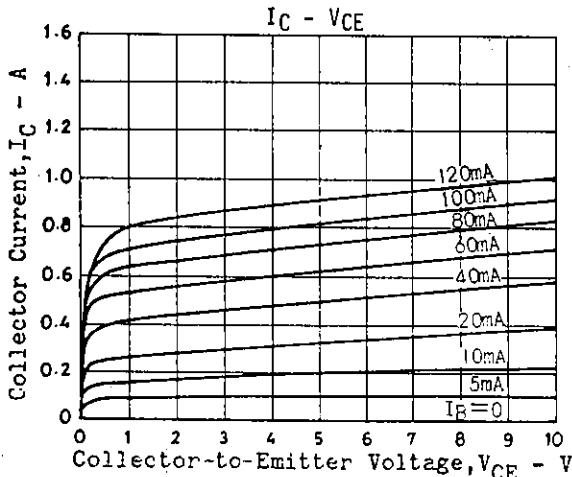
$V_{CC}=400V$,
 $5I_{B1}=-2.5I_{B2}=I_C=1A$
 $R_L=400ohms$

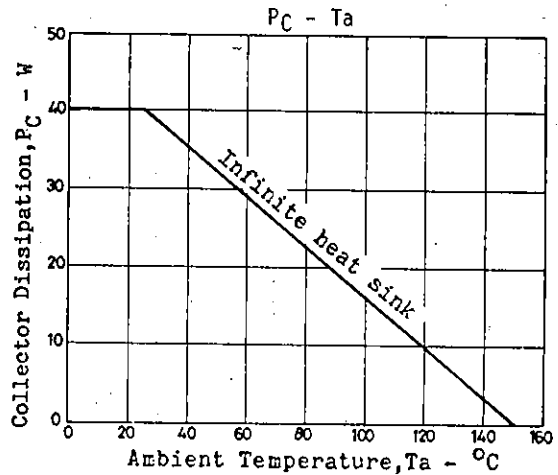
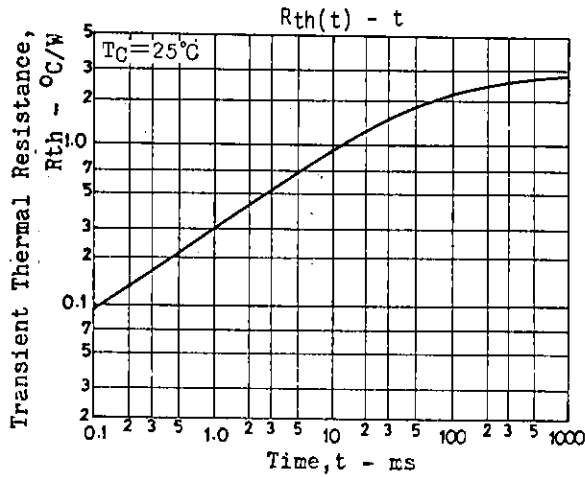
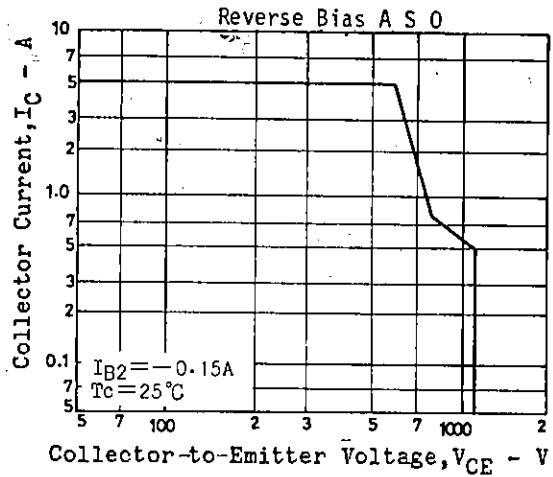
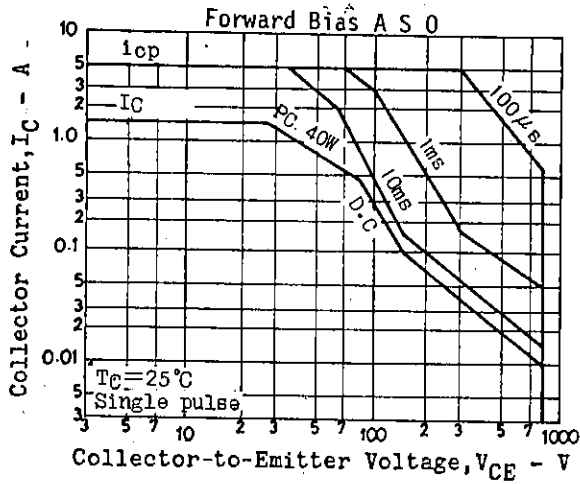
0.5 μs
 3.0 μs
 0.3 μs

Switching Time Test Circuit



Unit (resistance: Ω , capacitance: F)





■ No products described or contained herein are intended for use in surgical implants, life-support systems, aerospace equipment, nuclear power control systems, vehicles, disaster/crime-prevention equipment and the like, the failure of which may directly or indirectly cause injury, death or property loss.

■ Anyone purchasing any products described or contained herein for an above-mentioned use shall:

- ① Accept full responsibility and indemnify and defend SANYO ELECTRIC CO., LTD., its affiliates, subsidiaries and distributors and all their officers and employees, jointly and severally, against any and all claims and litigation and all damages, cost and expenses associated with such use;
- ② Not impose any responsibility for any fault or negligence which may be cited in any such claim or litigation on SANYO ELECTRIC CO., LTD., its affiliates, subsidiaries and distributors or any of their officers and employees jointly or severally.

■ Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. SANYO believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.